

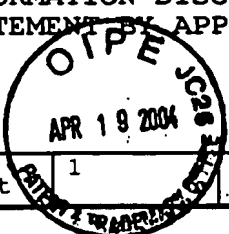
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Substitute for Form 1449A/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Application Number		10/669,694
	Filing Date		SEPTEMBER 23, 2003
	First Named Inventor		T. NAKAJIMA ET AL
	Group Art Unit		2614
	Examiner Name		Not Yet Assigned
Sheet 1 of 2	Attorney Docket Number		03579/LH



U.S. PATENT DOCUMENTS

Exam. Inits [*]	Cite No ¹	Document Number	Kind Code ²	Name of Patentee or Applicant	Publication Date MM-DD-YYYY	Relevant Portion
/A.A./	A	2002/0054713	A1	MATSUURA	05-09-2002	_____
/A.A./	B	5,619,998	A	ABDEL-MALEK et al.	04-15-1997	_____

FOREIGN PATENT DOCUMENTS

Exam Inits [*]	Cite No ¹	Offc ³	Document Number ⁴	Kind Code ⁵	Name of Patentee or Applicant	Publication Date MM-DD-YYYY	Relevant Portion	T ⁶

Examiner Signature	/Amir Alavi/	Date Considered	04/25/2007
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* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Unique citation designation number. ² See kinds of U.S. Patent Documents. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Place a check here if English translation is attached.

* English language abstract enclosed

DATE MAILED: April 19, 2004

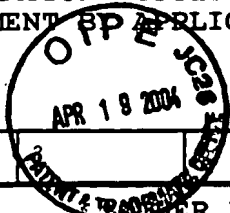
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OTHER PRIOR ART - NON-PATENT LITERATURE DOCUMENTS

Examiner Initials ¹	Cite No. ¹	Include name of author (in CAPITAL LETTERS), title of article, title of item, date, page(s), volume-issue number(s), publisher, city and/or country where published	T ²	
/A.A./ ↓	C	CHANG, S. G. et al., "Adaptive Wavelet Thresholding for Image Denoising and Compression" IEEE Transactions on Image Processing, IEEE Inc. New York, US, Vol. 9, No. 9, September 9, 2000, Pgs. 1532-1546, XP000963526, ISSN:1057-7149.	—	
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Examiner Signature		/Amir Alavi/	Date Considered	04/25/2007

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